

**IMSE-CNM****ABOUT IMSE**

Introduction
 How to find us
 Organization
 Staff
 Visiting IMSE

RESOURCES

Laboratories
 IT
 CAD tools

RESEARCH

Research Units
 Projects
 Catalog of ICs
 Patents

PUBLICATIONS

IMSE publications
 Library

JOB & TRAINING

At IMSE
 At CSIC

Materials and Devices Measurement Insights

Materials such as metallic materials, semiconductors, organic materials (such as polymers) and compound semiconductors have provided profound benefits over the last century. New and emerging materials such as oxide semiconductors, carbon nano tubes (CNT) and graphene promise to provide new benefits over the coming century.

Full Day Agenda:

09:00 Welcome & Overview.
 09:05 Challenges & Solutions for Material Science/Engineering Testing Application.
 09:45 Advanced Testing Solutions for Impedance Measurements.
 10:50 Coffee break.
 11:10 Devices & Material Characterization from DC to THz.
 12:50 Electrical Characterization of GaN & SiC devices.
 13:30 Closing.

Places are limited.

Registration is free at:

contactcenter_spain@keysight.com || [web](#) || Phone: 800 000 154

Instituto de Microelectrónica de Sevilla IMSE-CNM
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